

<b>Notice of References Cited</b>	Application/Control No. 10/816,540		Applicant(s)/Patent Under Reexamination LAU ET AL.	
	Examiner Binh V. Ho		Art Unit 2163	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0059253 A1	03-2006	Goodman et al.	709/223
*	B	US-2005/0193103 A1	09-2005	Drabik, John	709/221
*	C	US-6,311,278 B1	10-2001	Raanan et al.	726/14
*	D	US-2002/0116643 A1	08-2002	Raanan et al.	713/201
*	E	US-2003/0208481 A1	11-2003	Neumann, Ralf	707/3
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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